

Transaction Information

Tool ID	J78X
Tool Status	Connected
Location	Burlington, USA
Wafer Size	200 mm
Fab Section	Metrology
Tool Available Date	2024-01-11

General Product Information

Vendor Supplier	KLA Tencor
Model	AIT II
Vintage	2000
Serial No	9145
Asset Description	KLA-Tencor AIT II w/ ADC. Defect Inspection and Review for Semiconductors
Software Version	5.3.20.4
CIM	SECS, GEM
Process	Defect Inspection

Hardware Configuration (Fab)

System Type	Description	Quantity	Status
Main System	Defect Inspection	1	OK
Handler System	Dual		OK
Others			

Hardware Configuration (Subfab / Auxilliary Units)

Description	Quantity	Status
NONE		

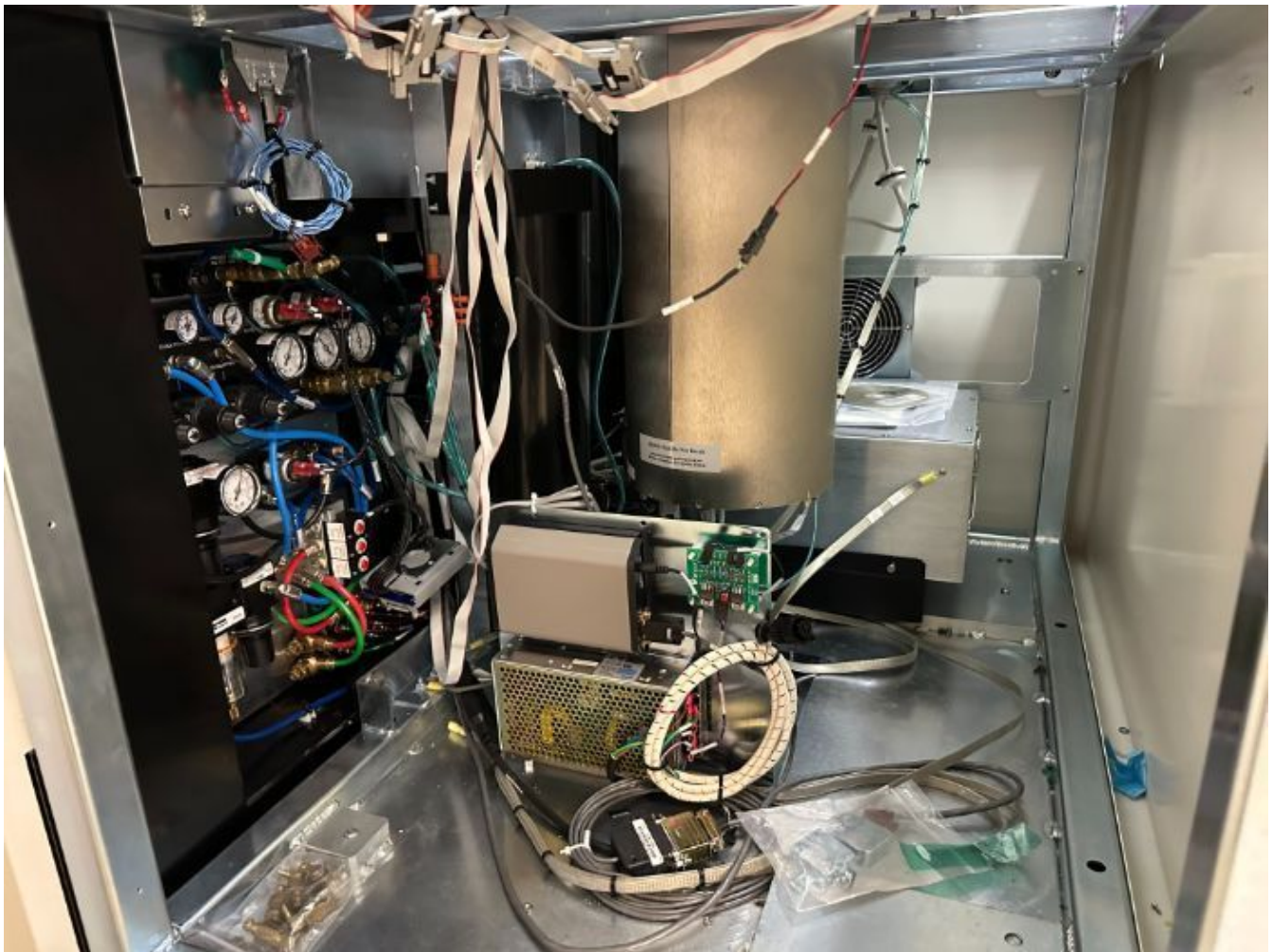
Missing/Faulty Parts / Accesories List

Description	Quantity
NONE	

Tool Pictures

General

Workstation, Loading Chamber, Front,
Sides, Rear



General

Workstation, Loading Chamber, Front,
Sides, Rear



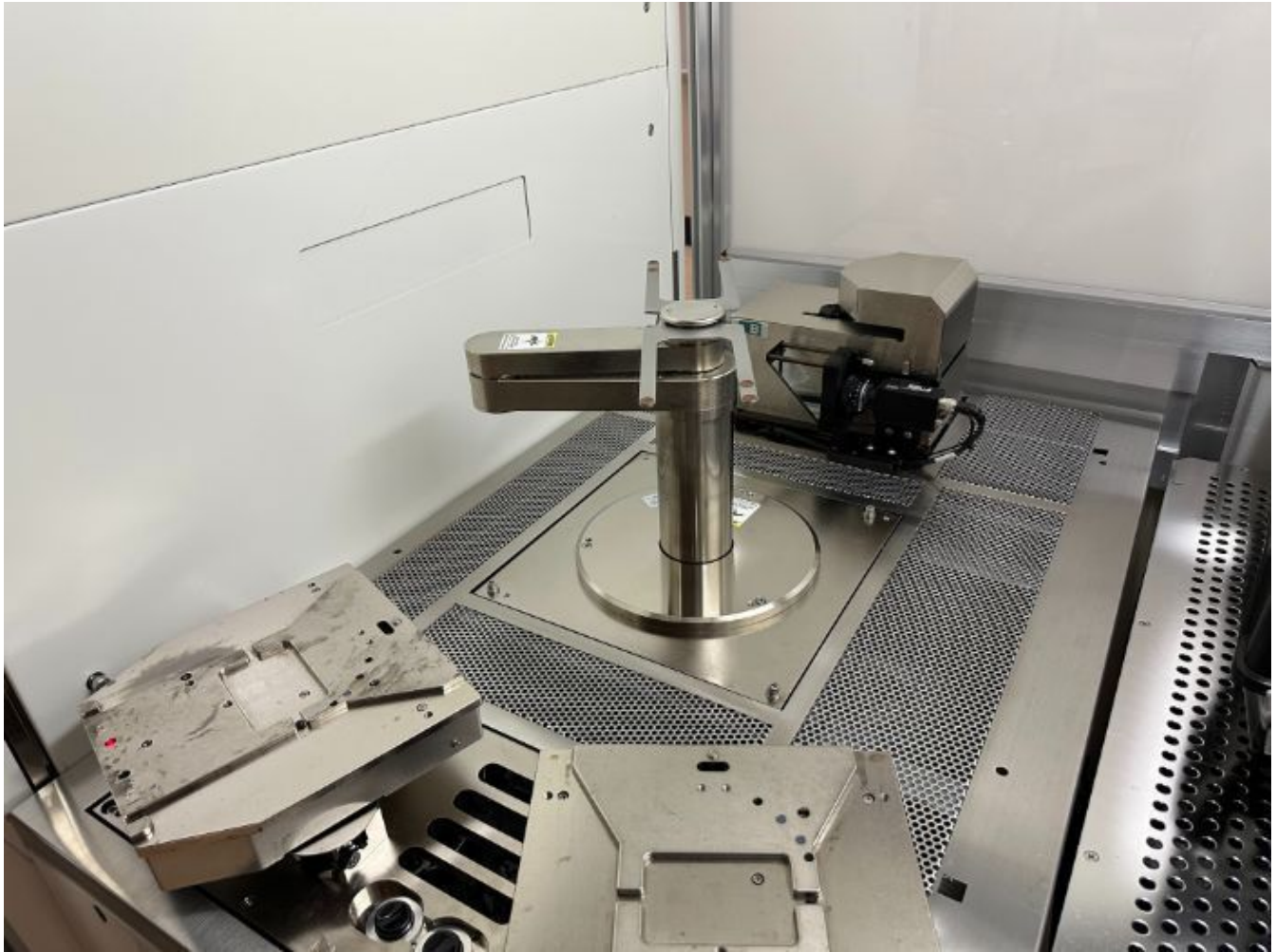
General

Workstation, Loading Chamber, Front, Sides, Rear



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Workstation, Loading Chamber, Front,
Sides, Rear



General

Workstation, Loading Chamber, Front,
Sides, Rear



General

Workstation, Loading Chamber, Front, Sides, Rear



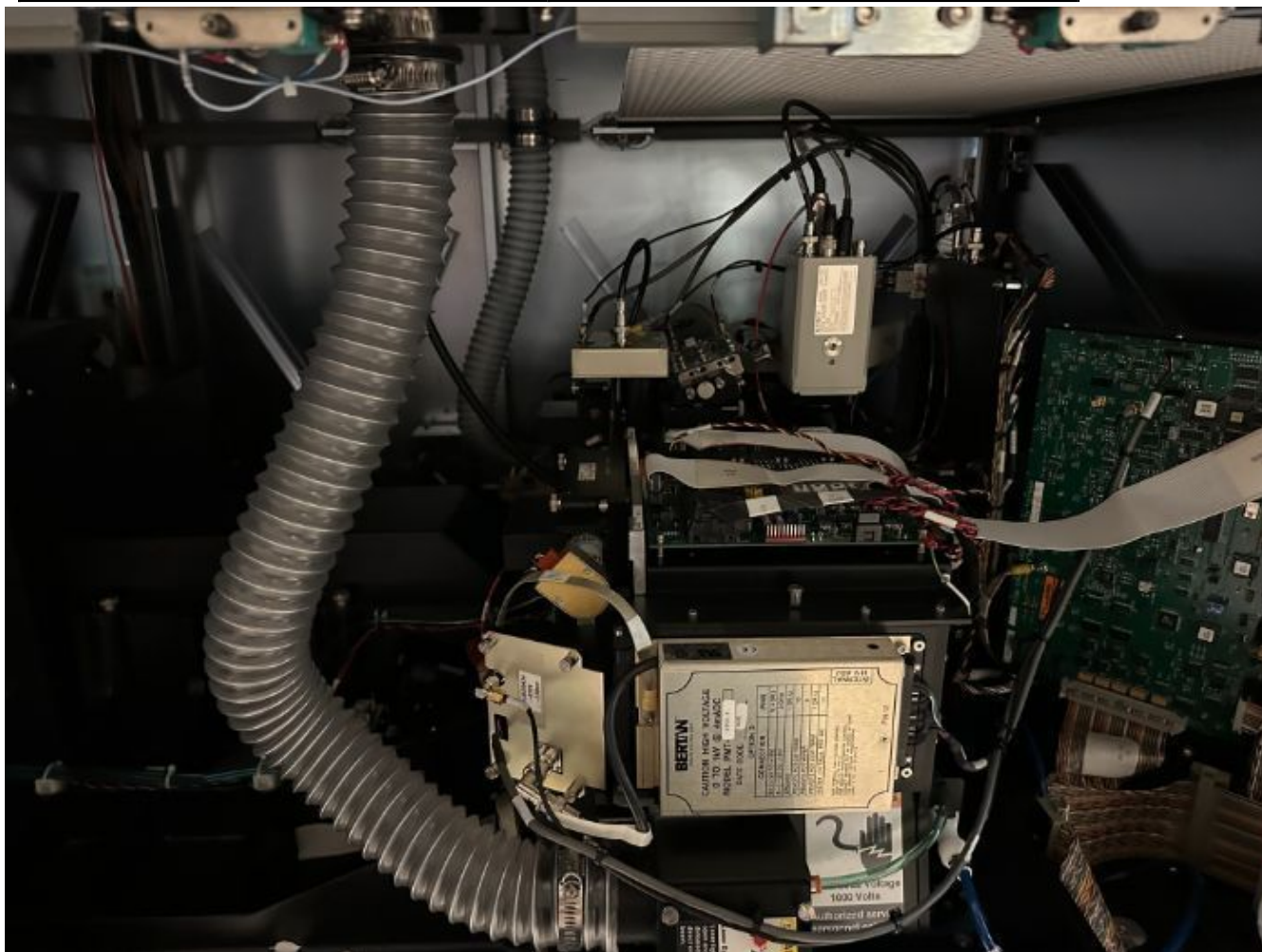
General

Workstation, Loading Chamber, Front,
Sides, Rear



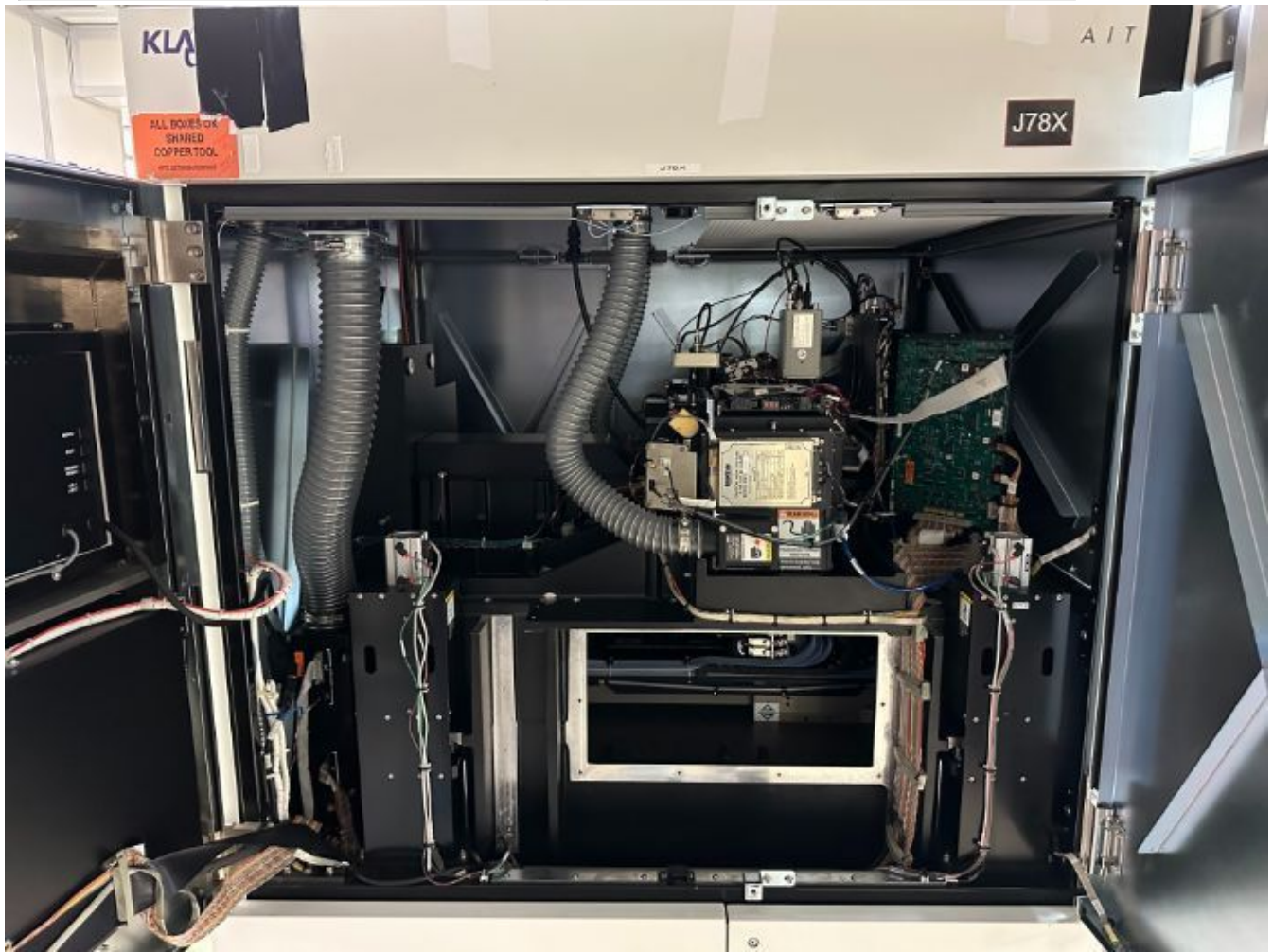
General

Workstation, Loading Chamber, Front,
Sides, Rear



General

Workstation, Loading Chamber, Front,
Sides, Rear



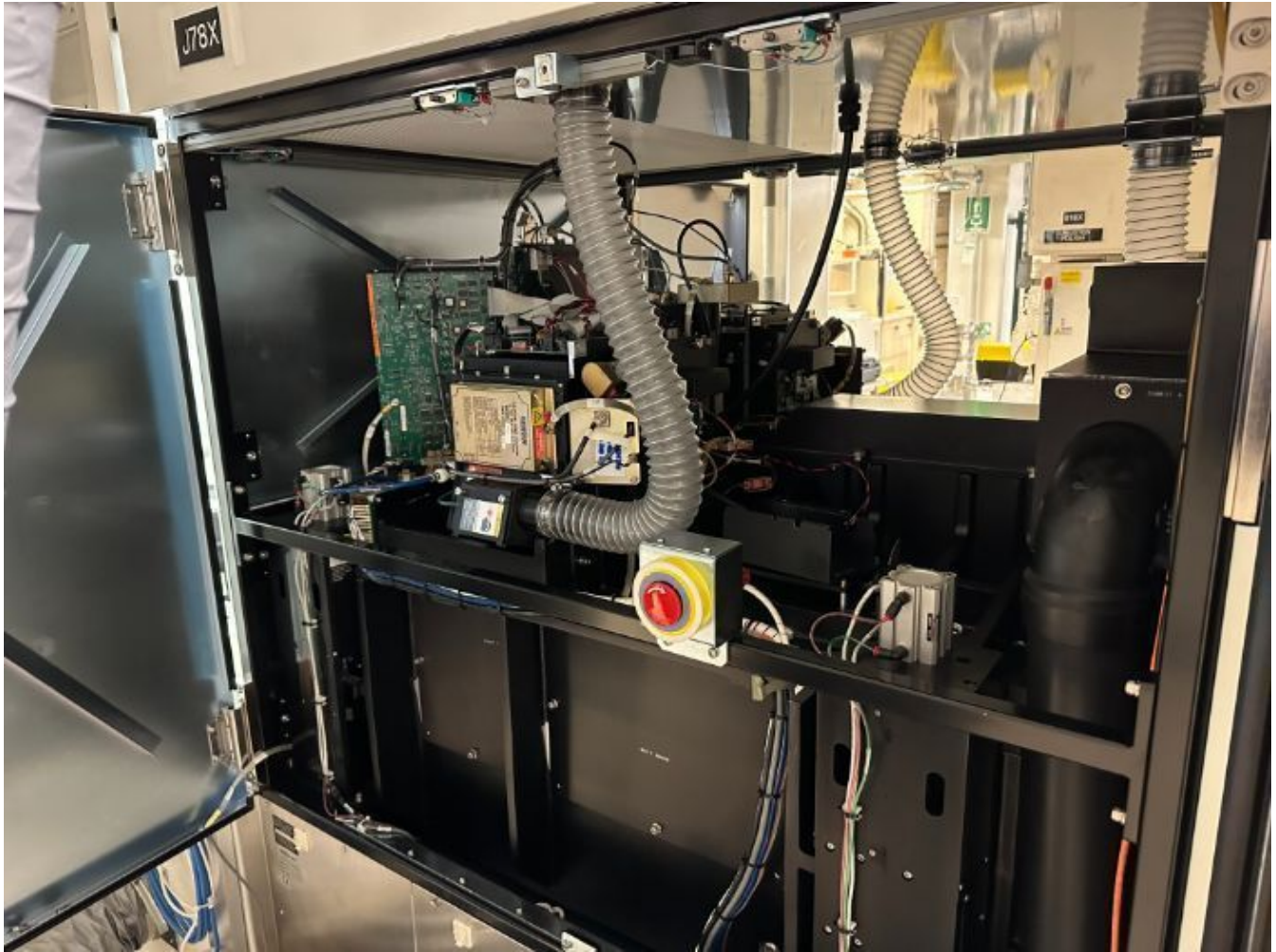
General

Workstation, Loading Chamber, Front,
Sides, Rear



General

Workstation, Loading Chamber, Front,
Sides, Rear



Additional Tool Data Files